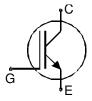
IGBT Chip in Fieldstop -technology

FEATURES:

- 1200V Fieldstop technology 120µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient

This chip is used for:

- IGBT Modules
- Applications:
- welding, SMPS, resonant applications



| Chip Type | V _{CE} | I _{Cn} | Die Size | Package | Ordering Code | |
|--------------|-----------------|-----------------|-----------------------------|--------------|---------------|--|
| SIGC42T120CQ | 1200V | 25A | 6.59 x 6.49 mm ² | sawn on foil | SP0002-04966 | |

MECHANICAL PARAMETER:

| Raster size | 6.59 x 6.49 | | | |
|---------------------------------|---|-----|--|--|
| Emitter pad size | 2 x (2.18 x 1.58) | | | |
| Gate pad size | 1.06 x 0.65 | | | |
| Area total / active | 42.8 / 33.5 | | | |
| Thickness | 120 | μm | | |
| Wafer size | 150 | mm | | |
| Flat position | 90 | grd | | |
| Max.possible chips per wafer | 332 pcs | | | |
| assivation frontside Photoimide | | | | |
| Emitter metallization | 3200 nm Al Si Cu | | | |
| Collector metallization | 1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding | | | |
| Die bond | electrically conductive glue or solder | | | |
| Wire bond | Al, <500μm | | | |
| Reject Ink Dot Size | Ø 0.65mm ; max 1.2mm | | | |
| Recommended Storage Environment | store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C | | | |

MAXIMUM RATINGS:

| Parameter | Symbol | Value | Unit |
|---|-----------------------------------|----------|------|
| Collector-emitter voltage, T _j =25 °C | V _{CE} | 1200 | V |
| DC collector current, limited by T _{jmax} | I _C | 1) | А |
| Pulsed collector current, t _p limited by T _{jmax} | I _{cpuls} | 75 | А |
| Gate emitter voltage | V _{GE} | ±20 | V |
| Operating junction and storage temperature | T _j , T _{stg} | -55 +150 | °C |

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

| Parameter | Symbol Conditions | | Value | | | Unit |
|--------------------------------------|----------------------|---|-------|------|------|------|
| | | | min. | typ. | max. | |
| Collector-emitter breakdown voltage | V _{(BR)CES} | V_{GE} =0V , I_{C} = 1.5mA | 1200 | | | |
| Collector-emitter saturation voltage | V _{CE(sat)} | V _{GE} =15V, I _C =25A | | 2.1 | | V |
| Gate-emitter threshold voltage | $V_{\rm GE(th)}$ | I_{C} =1mA , V_{GE} = V_{CE} | | 5.5 | | |
| Zero gate voltage collector current | I _{CES} | V_{CE} =1200V , V_{GE} =0V | | | 3 | μA |
| Gate-emitter leakage current | I _{GES} | V_{CE} =0V , V_{GE} =20V | | | 120 | nA |

ELECTRICAL CHARACTERISTICS (tested at component):

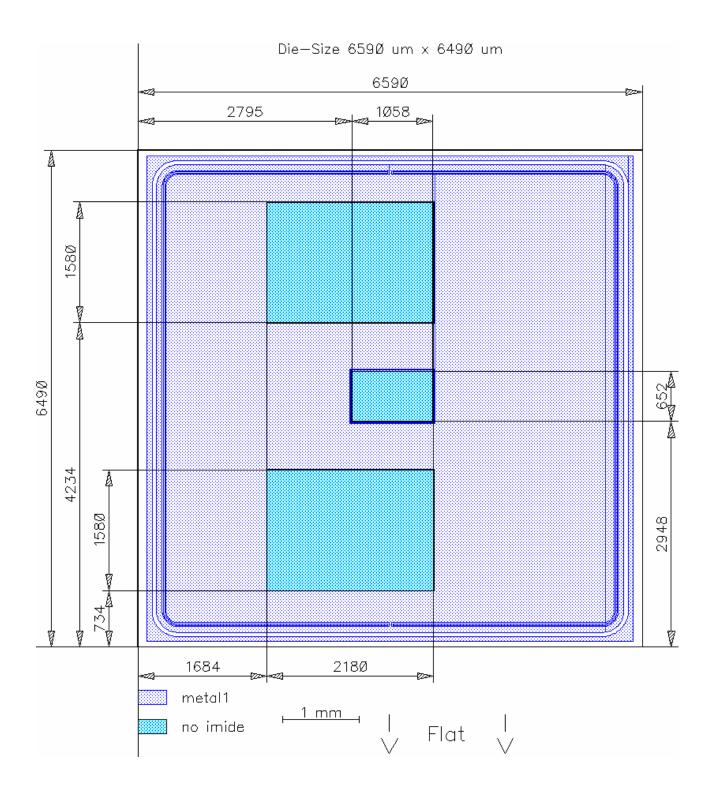
| Parameter | Symbol Conditions | Value | | | Unit | |
|------------------------------|-------------------|-----------------------|------|------|------|------|
| Falameter | Symbol | Conditions | min. | typ. | max. | Unit |
| Input capacitance | Ciss | V _{CE} =25V, | - | 2020 | | pF |
| Output capacitance | Coss | $V_{GE}=0V$, | - | 193 | | |
| Reverse transfer capacitance | Crss | <i>f</i> =1MHz | - | 64 | | |

SWITCHING CHARACTERISTICS (tested at component), Inductive Load

| Parameter | Symbol Conditions ¹⁾ | Value | | | Unit | |
|---------------------|---------------------------------|------------------------------------|------|------|------|------|
| | | Conditions | min. | typ. | max. | Unit |
| Turn-on delay time | t _{d(on)} | $T_{\rm j} = 125 ^{\circ} {\rm C}$ | - | 38 | | ns |
| Rise time | t _r | $V_{\rm CC} = 600 \text{V},$ | - | 25 | | |
| Turn-off delay time | $t_{d(off)}$ | ν _{GE} =-15/15V, | - | 250 | | |
| Fall time | t _f | <i>R</i> _G = 22Ω | - | 96 | | |

¹⁾ values also influenced by parasitic L- and C- in measurement and package.

CHIP DRAWING:



FURTHER ELECTRICAL CHARACTERISTICS:

| This chip data sheet refers to the device data sheet | |
|--|--|
|--|--|

DESCRIPTION:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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